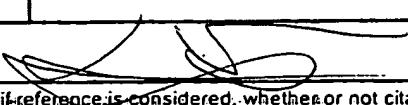


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 201326US2		SERIAL NO. New Application	
LIST OF REFERENCES CITED BY APPLICANT APR 23 2004 JC34		APPLICANT		Minoru TAKAYA, et al.			
		FILING DATE		HEREWITH		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO	
<i>JK</i>	AO	8-69712	03/12/96	Japan (with English Abstract)		X	
<i>JK</i>	AP	10-270255	10/09/98	Japan (with English Abstract)		X	
<i>JK</i>	AQ	11-192620	07/21/99	Japan (with English Abstract)		X	
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner 					Date Considered 03/06		
Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							



SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 201326US2	SERIAL NO. 09/749,800		
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT Minoru TAKAYA, et al.					
		FILING DATE December 28, 2000		GROUP 1773			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	3,993,626	11/23/76	J. J. LAURITO			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
	AO	25 01 843	06/16/76	GERMANY (with corr. US 3,993,626)	YES	NO	X
	AP	1 246 829	09/22/71	GREAT BRITAIN			
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ	<input type="checkbox"/> Additional References sheet(s) attached					
Examiner					Date Considered 03/06		

Examiner's initial if reference is considered; whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered; include copy of this form with next communication to applicant.

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 201326US2	SERIAL NO. 09/749,800	
<p>• LIST OF REFERENCES CITED BY APPLICANT</p> <p style="text-align: center;"><i>O I P E</i> <i>MAY 11 2004</i> <i>PATENT & TRADEMARK OFFICE</i></p>				APPLICANT Minoru TAKAYA, et al.		
		FILING DATE December 28, 2000			GROUP 1773	
U.S. PATENT DOCUMENTS						
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA 3,993,626	11/23/76	J. J. LAURITO			
	AB					
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	AE					
	AF					
	AG					
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	AN					
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
	AO 25 01 843	06/16/76	GERMANY (with corr. US 3,993,626)	YES	NO	X
	AP 1 246 829	09/22/71	GREAT BRITAIN			
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)						
	AW					
	AX					
	AY					
	AZ	<input type="checkbox"/> Additional References sheet(s) attached				
Examiner		Date Considered <i>03/06</i>				

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 201326US2	SERIAL NO. 09/749,800
LIST OF REFERENCES CITED BY APPLICANT <i>MAY 11 2004</i>		APPLICANT Minoru TAKAYA, et al.			
		FILING DATE December 28, 2000		GROUP 1773	
U.S. PATENT DOCUMENTS					
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
<i>✓</i>	AA 5,470,400	11/28/95	Y. BOGATIN, et al.		
	AB				
	AC				
	AD				
	AE				
	AF				
	AG				
	AH				
	AI				
	AJ				
	AK				
	AL				
	AM				
	AN				
FOREIGN PATENT DOCUMENTS					
	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO
<i>✓</i>	AO 6-204021	07/22/94	JAPAN (with English Abstract)		X
	AP 8-78798	03/22/96	JAPAN (with English Abstract)		X
<i>✓</i>	AQ 0 383 035	08/22/90	EUROPE		
<i>✓</i>	AR 0 878 984	11/18/98	EUROPE		
	AS				
	AT				
	AU				
	AV				
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)					
<i>✓</i>	AW	G. VIAU, et al., Journal of Applied Physics, vol. 76, no. 10, Part 2, XP-000508787, pages 6570-6572, "PREPARATION AND MICROWAVE CHARACTERIZATION OF SPHERICAL AND MONODISPERSE $Co_{20}Ni_{80}$ PARTICLES", November 15, 1994			
	AX				
	AY				
	AZ	<input type="checkbox"/> Additional References sheet(s) attached			
Examiner	<i>03/06</i>			Date Considered <i>03/06</i>	
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